

Characteristics ($T_j = 25^\circ\text{C}$)Kennwerte ($T_j = 25^\circ\text{C}$)

	Min.	Typ.	Max.
Collector-Emitter saturation voltage – Kollektor-Emitter-Sättigungsspg. ²⁾ - $I_C = 150\text{ mA}$, - $I_B = 15\text{ mA}$ - $I_C = 500\text{ mA}$, - $I_B = 50\text{ mA}$	- V_{CEsat} -	- -	0.40 V 0.75 V
Base-Emitter saturation voltage – Basis-Emitter-Sättigungsspannung ²⁾ - $I_C = 150\text{ mA}$, - $I_B = 15\text{ mA}$ - $I_C = 500\text{ mA}$, - $I_B = 50\text{ mA}$	- V_{BEsat} -	0.75 V -	0.95 V 1.3 V
Collector-Emitter cutoff current – Kollektor-Emitter-Reststrom - $V_{CE} = 35\text{ V}$, - $V_{EB} = 0,4\text{ V}$	- I_{CEX}	-	100 nA
Emitter-Base cutoff current – Emitter-Basis-Reststrom - $V_{CE} = 35\text{ V}$, - $V_{EB} = 0,4\text{ V}$	- I_{EBV}	-	100 nA
Gain-Bandwidth Product – Transitfrequenz - $I_C = 20\text{ mA}$, - $V_{CE} = 10\text{ V}$, $f = 100\text{ MHz}$	f_T	200 MHz	-
Collector-Base Capacitance – Kollektor-Basis-Kapazität - $V_{CB} = 5\text{ V}$, $I_E = i_e = 0$, $f = 1\text{ MHz}$	C_{CBO}	-	8.5 pF
Emitter-Base Capacitance – Emitter-Basis-Kapazität - $V_{EB} = 0.5\text{ V}$, $I_C = i_c = 0$, $f = 1\text{ MHz}$	C_{EBO}	-	30 pF
Switching times – Schaltzeiten (between 10% and 90% levels)			
delay time	t_d	-	15 ns
rise time	t_r	-	20 ns
storage time	t_s	-	225 ns
fall time	t_f	-	30 ns
Thermal resistance junction to ambient air Wärmewiderstand Sperrschicht – umgebende Luft	R_{thA}	< 420 K/W ¹⁾	
Recommended complementary NPN transistors Empfohlene komplementäre NPN-Transistoren	2N4401		

2 Tested with pulses $t_p = 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$ – Gemessen mit Impulsen $t_p = 300\text{ }\mu\text{s}$, Schaltverhältnis $\leq 2\%$

1 Mounted on P.C. board with 3 mm^2 copper pad at each terminal
Montage auf Leiterplatte mit 3 mm^2 Kupferbelag (Löt-pad) an jedem Anschluss